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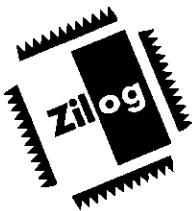


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Z86E04/E08

CMOS Z8 OTP MICROCONTROLLERS

PRODUCT DEVICES

Part Number	Oscillator Type	Operating V _{cc}	Operating Temperature	ROM (KB)	Package
Z86E0412PEC	Crystal	4.5V–5.5V	–40°C/105°C	1	18-Pin DIP
Z86E0412PSC1866	Crystal	4.5V–5.5V	0°C/70°C	1	18-Pin DIP
Z86E0412PSC1903	RC	4.5V–5.5V	0°C/70°C	1	18-Pin DIP
Z86E0412PEC1903	RC	4.5V–5.5V	–40°C/105°C	1	18-Pin DIP
Z86E0412SEC	Crystal	4.5V–5.5V	–40°C/105°C	1	18-Pin SOIC
Z86E0412SSC1866	Crystal	4.5V–5.5V	0°C/70°C	1	18-Pin SOIC
Z86E0412SSC1903	RC	4.5V–5.5V	0°C/70°C	1	18-Pin SOIC
Z86E0412SEC1903	RC	4.5V–5.5V	–40°C/105°C	1	18-Pin SOIC
Z86E0812PEC	Crystal	4.5V–5.5V	–40°C/105°C	2	18-Pin DIP
Z86E0812PSC1866	Crystal	4.5V–5.5V	0°C/70°C	2	18-Pin DIP
Z86E0812PSC1903	RC	4.5V–5.5V	0°C/70°C	2	18-Pin DIP
Z86E0812PEC1903	RC	4.5V–5.5V	–40°C/105°C	2	18-Pin DIP
Z86E0812SEC	Crystal	4.5V–5.5V	–40°C/105°C	2	18-Pin SOIC
Z86E0812SSC1866	Crystal	4.5V–5.5V	0°C/70°C	2	18-Pin SOIC
Z86E0812SSC1903	RC	4.5V–5.5V	0°C/70°C	2	18-Pin SOIC
Z86E0812SEC1903	RC	4.5V–5.5V	–40°C/105°C	2	18-Pin SOIC

Several key product features of the extensive family of Zilog Z86E04/E08 CMOS OTP microcontrollers are presented in the above table. This table enables the user to identify which of the E04/E08 product variants most closely match the user's application requirements.

FEATURES

- 14 Input/Output Lines
- Six Vectored, Prioritized Interrupts (3 falling edge, 1 rising edge, 2 timers)
- Two Analog Comparators
- Program Options:
 - Low Noise
 - ROM Protect
 - Auto Latch
 - Watch-Dog Timer (WDT)
 - EPROM/Test Mode Disable
- Two Programmable 8-Bit Counter/Timers, Each with 6-Bit Programmable Prescaler
- WDT/ Power-On Reset (POR)
- On-Chip Oscillator that Accepts XTAL, Ceramic Resonance, LC, RC, or External Clock
- Clock-Free WDT Reset
- Low-Power Consumption (50 mw typical)
- Fast Instruction Pointer (1 μ s @ 12 MHz)
- RAM Bytes (125)

GENERAL DESCRIPTION

Zilog's Z86E04/E08 Microcontrollers (MCU) are One-Time Programmable (OTP) members of Zilog's single-chip Z8® MCU family that allow easy software development, debug, prototyping, and small production runs not economically desirable with masked ROM versions.

For applications demanding powerful I/O capabilities, the Z86E04/E08's dedicated input and output lines are grouped into three ports, and are configurable under software control to provide timing, status signals, or parallel I/O.

Two on-chip counter/timers, with a large number of user selectable modes, offload the system of administering real-time tasks such as counting/timing and I/O data communications.

Note: All Signals with an overline, “ $\overline{}$ ”, are active Low, for example: $B\overline{W}$ (WORD is active Low); $\overline{B}W$ (BYTE is active Low, only).

Power connections follow conventional descriptions below:

Connection	Circuit	Device
Power	V_{CC}	V_{DD}
Ground	GND	V_{SS}

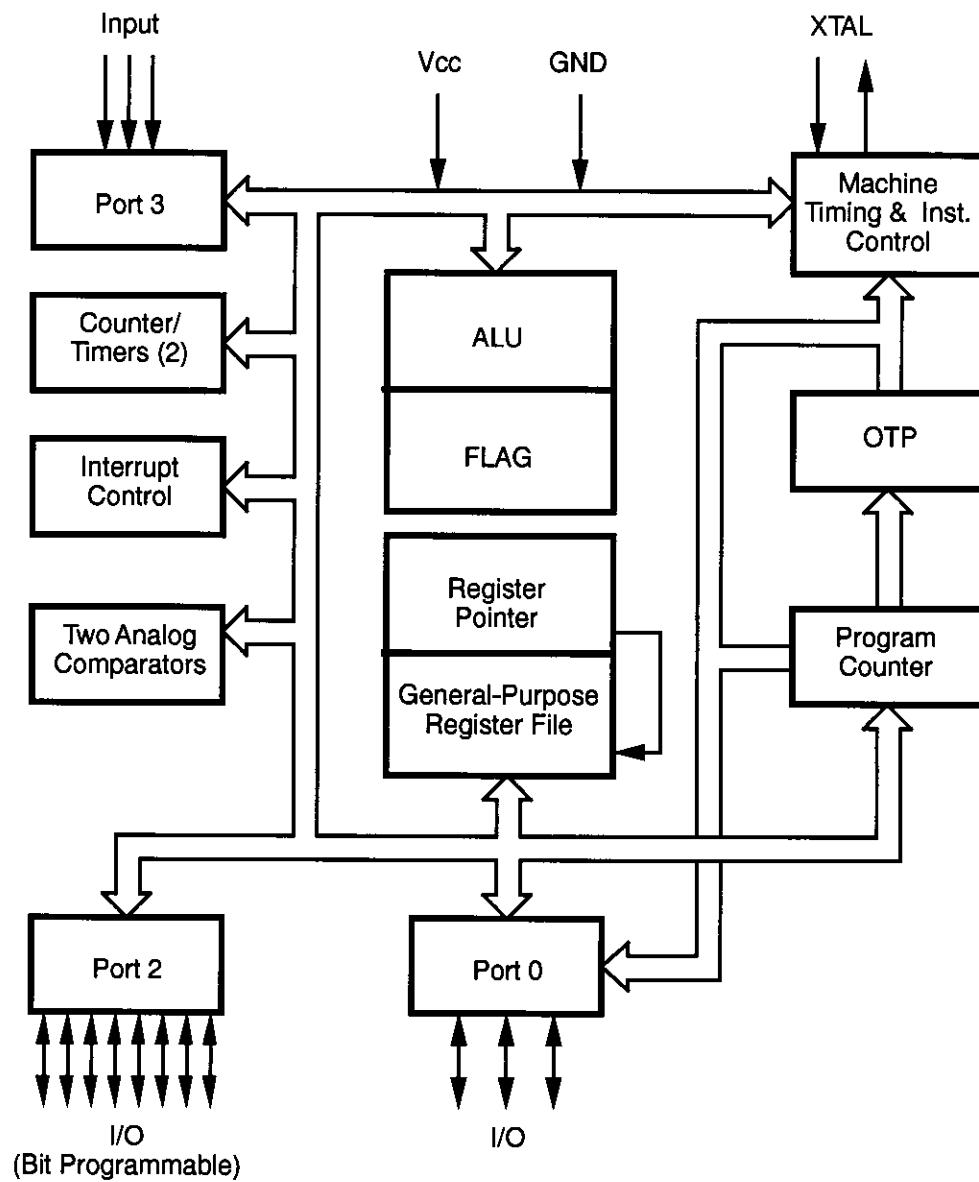


Figure 1. Functional Block Diagram

GENERAL DESCRIPTION (Continued)

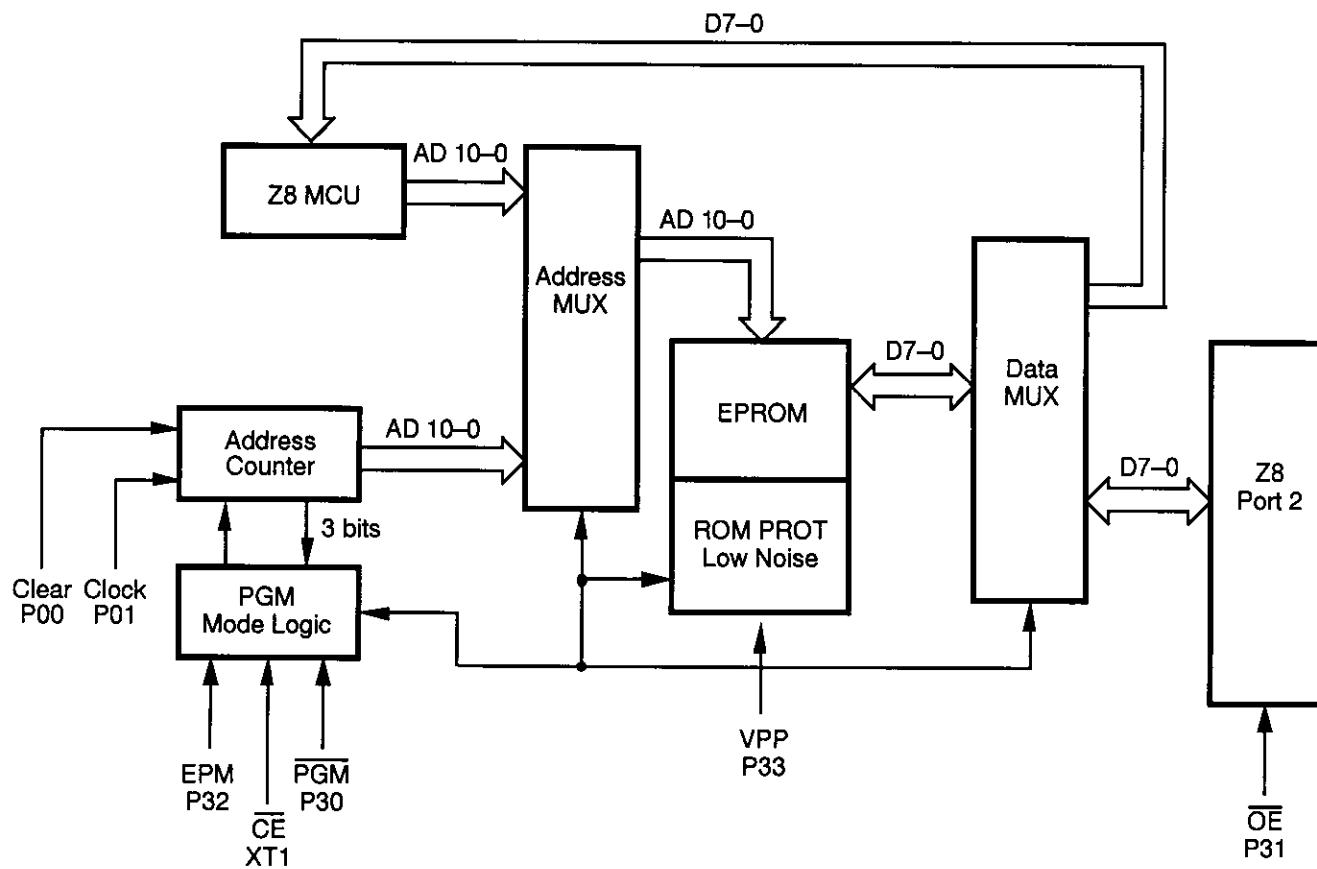
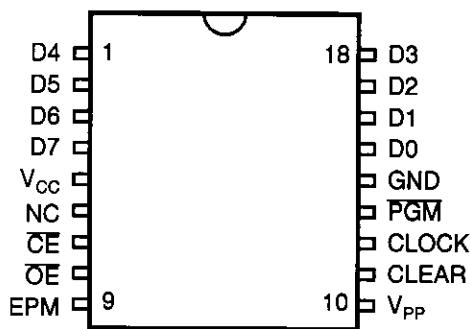
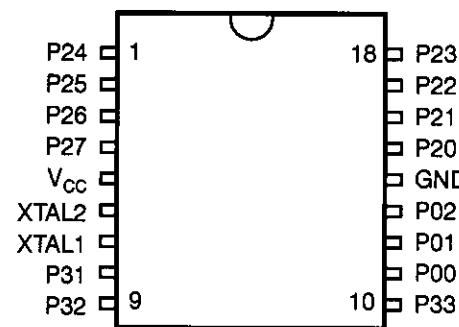


Figure 2. EPROM Programming Mode Block Diagram

PIN DESCRIPTION**Figure 3. 18-Pin EPROM Mode Configuration****Figure 4. 18-Pin DIP/SOIC Mode Configuration****Table 1. 18-Pin DIP Pin Identification**

EPROM Programming Mode			
Pin #	Symbol	Function	Direction
1–4	D4–D7	Data 4, 5, 6, 7	In/Output
5	V _{CC}	Power Supply	
6	NC	No Connection	
7	CE	Chip Enable	Input
8	OE	Output Enable	Input
9	EPM	EPROM Prog Mode	Input
10	V _{PP}	Prog Voltage	Input
11	Clear	Clear Clock	Input
12	Clock	Address	Input
13	PGM	Prog Mode	Input
14	GND	Ground	
15–18	D0–D3	Data 0,1,2,3	In/Output

Table 2. 18-Pin DIP/SOIC Pin Identification

Standard Mode			
Pin #	Symbol	Function	Direction
1–4	P24–P27	Port 2, Pins 4,5,6,7	In/Output
5	V _{CC}	Power Supply	
6	XTAL2	Crystal Osc. Clock	Output
7	XTAL1	Crystal Osc. Clock	Input
8	P31	Port 3, Pin 1, AN1	Input
9	P32	Port 3, Pin 2, AN2	Input
10	P33	Port 3, Pin 3, REF	Input
11–13	P00–P02	Port 0, Pins 0,1,2	In/Output
14	GND	Ground	
15–18	P20–P23	Port 2, Pins 0,1,2,3	In/Output

ABSOLUTE MAXIMUM RATINGS

Stresses greater than those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at any condition above those indicated in the operational sections of these specifications is not implied. Exposure to absolute maximum rating conditions for an extended period may affect device reliability. Total power

dissipation should not exceed 462 mW for the package. Power dissipation is calculated as follows:

$$\begin{aligned}\text{Total Power Dissipation} = & V_{DD} \times [I_{DD} - (\text{sum of } I_{OH})] \\ & + \text{sum of } [(V_{DD} - V_{OH}) \times I_{OH}] \\ & + \text{sum of } (V_{OL} \times I_{OL})\end{aligned}$$

Parameter	Min	Max	Units	Note
Ambient Temperature under Bias	-40	+105	C	
Storage Temperature	-65	+150	C	
Voltage on any Pin with Respect to V _{SS}	-0.7	+12	V	1
Voltage on V _{DD} Pin with Respect to V _{SS}	-0.3	+7	V	
Voltage on Pins 7, 8, 9, 10 with Respect to V _{SS}	-0.6	V _{DD} +1	V	2
Total Power Dissipation		1.65	W	
Maximum Allowable Current out of V _{SS}	300		mA	
Maximum Allowable Current into V _{DD}	220		mA	
Maximum Allowable Current into an Input Pin	-600	+600	µA	3
Maximum Allowable Current into an Open-Drain Pin	-600	+600	µA	4
Maximum Allowable Output Current Sunk by Any I/O Pin	25		mA	
Maximum Allowable Output Current Sourced by Any I/O Pin	25		mA	
Total Maximum Output Current Sunk by a Port	60		mA	
Total Maximum Output Current Sourced by a Port	45		mA	

Notes:

1. This applies to all pins except where otherwise noted. Maximum current into pin must be $\pm 600 \mu A$.
2. There is no input protection diode from pin to V_{DD} (not applicable to EPROM Mode).
3. This excludes Pin 6 and Pin 7.
4. Device pin is not at an output Low state.

STANDARD TEST CONDITIONS

The characteristics listed below apply for standard test conditions as noted. All voltages are referenced to Ground. Positive current flows into the referenced pin (Figure 5).

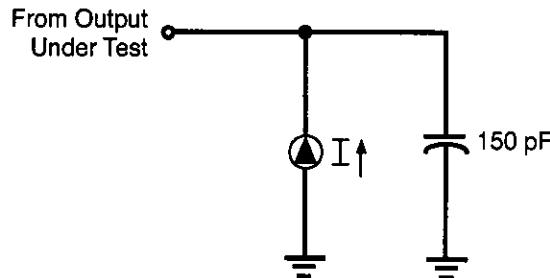


Figure 5. Test Load Diagram

CAPACITANCE

$T_A = 25^\circ\text{C}$, $V_{CC} = \text{GND} = 0\text{V}$, $f = 1.0 \text{ MHz}$, unmeasured pins returned to GND.

Parameter	Min	Max
Input capacitance	0	10 pF
Output capacitance	0	20 pF
I/O capacitance	0	25 pF

DC ELECTRICAL CHARACTERISTICS

Standard Temperature

Sym	Parameter	V_{CC} [4]	$T_A = 0^\circ C$ to $+70^\circ C$		Typical		Notes
			Min	Max	@ 25°C	Units	
V_{INMAX}	Max Input Voltage	4.5V		12		V	$I_{IN} < 250 \mu A$
		5.5V		12		V	$I_{IN} < 250 \mu A$
V_{CH}	Clock Input High Voltage	4.5V	0.8 V_{CC}	$V_{CC} + 0.3$	2.8	V	Driven by External Clock Generator
		5.5V	0.8 V_{CC}	$V_{CC} + 0.3$	2.8	V	Driven by External Clock Generator
V_{CL}	Clock Input Low Voltage	4.5V	$V_{SS} - 0.3$	0.2 V_{CC}	1.7	V	Driven by External Clock Generator
		5.5V	$V_{SS} - 0.3$	0.2 V_{CC}	1.7	V	Driven by External Clock Generator
V_{IH}	Input High Voltage	4.5V	0.7 V_{CC}	$V_{CC} + 0.3$	2.8	V	
		5.5V	0.7 V_{CC}	$V_{CC} + 0.3$	2.8	V	
V_{IL}	Input Low Voltage	4.5V	$V_{SS} - 0.3$	0.2 V_{CC}	1.5	V	
		5.5V	$V_{SS} - 0.3$	0.2 V_{CC}	1.5	V	
V_{OH}	Output High Voltage	4.5V	$V_{CC} - 0.4$		4.8	V	$I_{OH} = -2.0 \text{ mA}$
		5.5V	$V_{CC} - 0.4$		4.8	V	$I_{OH} = -2.0 \text{ mA}$
		4.5V	$V_{CC} - 0.4$		4.8	V	Low Noise @ $I_{OH} = -0.5 \text{ mA}$
		5.5V	$V_{CC} - 0.4$		4.8	V	Low Noise @ $I_{OH} = -0.5 \text{ mA}$
V_{OL1}	Output Low Voltage	4.5V	0.8		0.1	V	$I_{OL} = +4.0 \text{ mA}$
		5.5V	0.4		0.1	V	$I_{OL} = +4.0 \text{ mA}$
		4.5V	0.4		0.1	V	Low Noise @ $I_{OL} = 1.0 \text{ mA}$
		5.5V	0.4		0.1	V	Low Noise @ $I_{OL} = 1.0 \text{ mA}$
V_{OL2}	Output Low Voltage	4.5V	0.8		0.8	V	$I_{OL} = +12 \text{ mA}$,
		5.5V	0.8		0.8	V	$I_{OL} = +12 \text{ mA}$,
V_{OFFSET}	Comparator Input Offset Voltage	4.5V	25.0		10.0	mV	
		5.5V	25.0		10.0	mV	
V_{LV}	V _{CC} Low Voltage Auto Reset		2.2	3.0	2.8	V	@ 6 MHz Max. Int. CLK Freq.
I_{IL}	Input Leakage (Input Bias Current of Comparator)	4.5V	-1.0	1.0		μA	$V_{IN} = 0V, V_{CC}$
		5.5V	-1.0	1.0		μA	$V_{IN} = 0V, V_{CC}$
I_{OL}	Output Leakage	4.5V	-1.0	1.0		μA	$V_{IN} = 0V, V_{CC}$
		5.5V	-1.0	1.0		μA	$V_{IN} = 0V, V_{CC}$
V_{ICR}	Comparator Input Common Mode Voltage Range		0	$V_{CC} - 1.0$		V	

Sym	Parameter	V _{cc} [4]	T _A = 0°C to +70°C Typical				Notes
			Min	Max	@ 25°C	Units	
I _{CC}	Supply Current	4.5V	11.0	6.8	mA	All Output and I/O Pins Floating @ 2 MHz	5,7
		5.5V	11.0	6.8	mA	All Output and I/O Pins Floating @ 2 MHz	5,7
		4.5V	15.0	8.2	mA	All Output and I/O Pins Floating @ 8 MHz	5,7
		5.5V	15.0	8.2	mA	All Output and I/O Pins Floating @ 8 MHz	5,7
		4.5V	20.0	12.0	mA	All Output and I/O Pins Floating @ 12 MHz	5,7
		5.5V	20.0	12.0	mA	All Output and I/O Pins Floating @ 12 MHz	5,7
I _{CC1}	Standby Current	4.5V	4.0	2.5	mA	HALT Mode V _{IN} = 0V, V _{CC} @ 2 MHz	5,7
		5.5V	4.0	2.5	mA	HALT Mode V _{IN} = 0V, V _{CC} @ 2 MHz	5,7
		4.5V	5.0	3.0	mA	HALT Mode V _{IN} = 0V, V _{CC} @ 8 MHz	5,7
		5.5V	5.0	3.0	mA	HALT Mode V _{IN} = 0V, V _{CC} @ 8 MHz	5,7
		4.5V	7.0	4.0	mA	HALT Mode V _{IN} = 0V, V _{CC} @ 12 MHz	5,7
		5.5V	7.0	4.0	mA	HALT Mode V _{IN} = 0V, V _{CC} @ 12 MHz	5,7
I _{CC}	Supply Current (Low Noise Mode)	4.5V	11.0	6.8	mA	All Output and I/O Pins Floating @ 1 MHz	7
		5.5V	11.0	6.8	mA	All Output and I/O Pins Floating @ 1 MHz	7
		4.5V	13.0	7.5	mA	All Output and I/O Pins Floating @ 2 MHz	7
		5.5V	13.0	7.5	mA	All Output and I/O Pins Floating @ 2 MHz	7
		4.5V	15.0	8.2	mA	All Output and I/O Pins Floating @ 4 MHz	7
		5.5V	15.0	8.2	mA	All Output and I/O Pins Floating @ 4 MHz	7

DC ELECTRICAL CHARACTERISTICS (Continued)

Sym	Parameter	V_{CC} [4]	$T_A = 0^\circ C$ to $+70^\circ C$			Units	Conditions	Notes
			Min	Max	Typical @ 25°C			
I_{CC1}	Standby Current (Low Noise Mode)	4.5V		4.0	2.5	mA	HALT Mode $V_{IN} = 0V$, V_{CC} @ 1 MHz	7
		5.5V		4.0	2.5	mA	HALT Mode $V_{IN} = 0V$, V_{CC} @ 1 MHz	7
		4.5V		4.5	2.8	mA	HALT Mode $V_{IN} = 0V$, V_{CC} @ 2 MHz	7
		5.5V		4.5	2.8	mA	HALT Mode $V_{IN} = 0V$, V_{CC} @ 2 MHz	7
		4.5V		5.0	3.0	mA	HALT Mode $V_{IN} = 0V$, V_{CC} @ 4 MHz	7
		5.5V		5.0	3.0	mA	HALT Mode $V_{IN} = 0V$, V_{CC} @ 4 MHz	7
I_{CC2}	Standby Current	4.5V	10.0	1.0	μA	STOP Mode $V_{IN} = 0V$, V_{CC} WDT is not Running	7,8	
		5.5V	10.0	1.0	μA	STOP Mode $V_{IN} = 0V$, V_{CC} WDT is not Running	7,8	
I_{ALL}	Auto Latch Low Current	4.5V	32.0	16	μA	$0V < V_{IN} < V_{CC}$		
		5.5V	32.0	16	μA	$0V < V_{IN} < V_{CC}$		
I_{ALH}	Auto Latch High Current	4.5V	-16.0	-8.0	μA	$0V < V_{IN} < V_{CC}$		
		5.5V	-16.0	-8.0	μA	$0V < V_{IN} < V_{CC}$		

Notes:

1. Port 2 and Port 0 only
2. $V_{SS} = 0V = GND$
3. The device operates down to V_{LV} of the specified frequency for V_{LV} . The minimum operational V_{CC} is determined on the value of the voltage V_{LV} at the ambient temperature. The V_{LV} increases as the temperature decreases.
4. $V_{CC} = 4.5$ to $5.5V$, typical values measured at $V_{CC} = 5.0V$.
The V_{CC} voltage specification of $5.5V$ guarantees $5.0V \pm 0.5V$ with typical values measured at $V_{CC} = 5.0V$.
5. Standard Mode (not Low EMI Mode)
6. Z86E08 only
7. All outputs unloaded and all inputs are at V_{CC} or V_{SS} level.
8. If analog comparator is selected, then the comparator inputs must be at V_{CC} level.

DC ELECTRICAL CHARACTERISTICS

Extended Temperature

Sym	Parameter	V _{cc} [4]	T _A = -40°C to +105°C		Typical @ 25°C	Units	Conditions	Notes
			Min	Max				
V _{INMAX}	Max Input Voltage	4.5V		12.0		V	I _{IN} < 250 µA	1
		5.5V		12.0		V	I _{IN} < 250 µA	1
V _{CH}	Clock Input High Voltage	4.5V	0.8 V _{CC}	V _{CC} +0.3	2.8	V	Driven by External Clock Generator	
		5.5V	0.8 V _{CC}	V _{CC} +0.3	2.8	V	Driven by External Clock Generator	
V _{CL}	Clock Input Low Voltage	4.5V	V _{SS} -0.3	0.2 V _{CC}	1.7	V	Driven by External Clock Generator	
		5.5V	V _{SS} -0.3	0.2 V _{CC}	1.7	V	Driven by External Clock Generator	
V _{IH}	Input High Voltage	4.5V	0.7 V _{CC}	V _{CC} +0.3	2.8	V		
		5.5V	0.7 V _{CC}	V _{CC} +0.3	2.8	V		
V _{IL}	Input Low Voltage	4.5V	V _{SS} -0.3	0.2 V _{CC}	1.5	V		
		5.5V	V _{SS} -0.3	0.2 V _{CC}	1.5	V		
V _{OH}	Output High Voltage	4.5V	V _{CC} -0.4		4.8	V	I _{OH} = -2.0 mA	5
		5.5V	V _{CC} -0.4		4.8	V	I _{OH} = -2.0 mA	5
		4.5V	V _{CC} -0.4			V	Low Noise @ I _{OH} = -0.5 mA	
		5.5V	V _{CC} -0.4			V	Low Noise @ I _{OH} = -0.5 mA	
V _{OL1}	Output Low Voltage	4.5V		0.4	0.1	V	I _{OL} = +4.0 mA	5
		5.5V		0.4	0.1	V	I _{OL} = +4.0 mA	5
		4.5V		0.4	0.1	V	Low Noise @ I _{OL} = 1.0 mA	
		5.5V		0.4	0.1	V	Low Noise @ I _{OL} = 1.0 mA	
V _{OL2}	Output Low Voltage	4.5V		1.0	0.3	V	I _{OL} = +12 mA,	5
		5.5V		1.0	0.3	V	I _{OL} = +12 mA,	5
V _{OFFSET}	Comparator Input Offset Voltage	4.5V		25.0	10.0	mV		
		5.5V		25.0	10.0	mV		
V _{LV}	V _{CC} Low Voltage Auto Reset		1.8	3.8	2.8	V	@ 6 MHz Max. Int. CLK Freq.	3
I _{IL}	Input Leakage (Input Bias Current of Comparator)	4.5V		-1.0	1.0	µA	V _{IN} = 0V, V _{CC}	
		5.5V		-1.0	1.0	µA	V _{IN} = 0V, V _{CC}	
I _{OL}	Output Leakage	4.5V		-1.0	1.0	µA	V _{IN} = 0V, V _{CC}	
		5.5V		-1.0	1.0	µA	V _{IN} = 0V, V _{CC}	
V _{ICR}	Comparator Input Common Mode Voltage Range	0	V _{CC} -1.5			V		

DC ELECTRICAL CHARACTERISTICS (Continued)

Sym	Parameter	V_{CC} [4]	$T_A = -40^\circ C$ to $+105^\circ C$		Typical @ 25°C	Units	Conditions	Notes
			Min	Max				
I_{CC}	Supply Current	4.5V	11.0	6.8	mA	All Output and I/O Pins Floating @ 2 MHz	5,7	
		5.5V	11.0	6.8	mA	All Output and I/O Pins Floating @ 2 MHz	5,7	
		4.5V	15.0	8.2	mA	All Output and I/O Pins Floating @ 8 MHz	5,7	
		5.5V	15.0	8.2	mA	All Output and I/O Pins Floating @ 8 MHz	5,7	
		4.5V	20.0	12.0	mA	All Output and I/O Pins Floating @ 12 MHz	5,7	
		5.5V	20.0	12.0	mA	All Output and I/O Pins Floating @ 12 MHz	5,7	
I_{CC1}	Standby Current	4.5V	5.0	2.5	mA	HALT Mode $V_{IN} = 0V$, $V_{CC} @ 2$ MHz	5,7	
		5.5V	5.0	2.5	mA	HALT Mode $V_{IN} = 0V$, $V_{CC} @ 2$ MHz	5,7	
		4.5V	5.0	3.0	mA	HALT Mode $V_{IN} = 0V$, $V_{CC} @ 8$ MHz	5,7	
		5.5V	5.0	3.0	mA	HALT Mode $V_{IN} = 0V$, $V_{CC} @ 8$ MHz	5,7	
		4.5V	7.0	4.0	mA	HALT Mode $V_{IN} = 0V$, $V_{CC} @ 12$ MHz	5,7	
		5.5V	7.0	4.0	mA	HALT Mode $V_{IN} = 0V$, $V_{CC} @ 12$ MHz	5,7	
I_{CC}	Supply Current (Low Noise Mode)	4.5V	11.0	6.8	mA	All Output and I/O Pins Floating @ 1 MHz	7	
		5.5V	11.0	6.8	mA	All Output and I/O Pins Floating @ 1 MHz	7	
		4.5V	13.0	7.5	mA	All Output and I/O Pins Floating @ 2 MHz	7	
		5.5V	13.0	7.5	mA	All Output and I/O Pins Floating @ 2 MHz	7	
		4.5V	15.0	8.2	mA	All Output and I/O Pins Floating @ 4 MHz	7	
		5.5V	15.0	8.2	mA	All Output and I/O Pins Floating @ 4 MHz	7	

Sym	Parameter	V _{CC} [4]	T _A = -40°C to +105°C		Typical @ 25°C	Units	Conditions	Notes
			Min	Max				
I _{CC1}	Standby Current (Low Noise Mode)	4.5V		4.0	2.5	mA	HALT Mode V _{IN} = 0V, V _{CC} @ 1 MHz	7
		5.5V		4.0	2.5	mA	HALT Mode V _{IN} = 0V, V _{CC} @ 1 MHz	7
		4.5V		4.5	2.8	mA	HALT Mode V _{IN} = 0V, V _{CC} @ 2 MHz	7
		5.5V		4.5	2.8	mA	HALT Mode V _{IN} = 0V, V _{CC} @ 2 MHz	7
		4.5V		5.0	3.0	mA	HALT Mode V _{IN} = 0V, V _{CC} @ 4 MHz	7
		5.5V		5.0	3.0	mA	HALT Mode V _{IN} = 0V, V _{CC} @ 4 MHz	7
I _{CC2}	Standby Current	4.5V		20	1.0	µA	STOP Mode V _{IN} = 0V, V _{CC} WDT is not Running	7,8
		5.5V		20	1.0	µA	STOP Mode V _{IN} = 0V, V _{CC} WDT is not Running	7,8
I _{ALL}	Auto Latch Low Current	4.5V		40	16	µA	0V < V _{IN} < V _{CC}	
		5.5V		40	16	µA	0V < V _{IN} < V _{CC}	
I _{ALH}	Auto Latch High Current	4.5V		-20.0	-8.0	µA	0V < V _{IN} < V _{CC}	
		5.5V		-20.0	-8.0	µA	0V < V _{IN} < V _{CC}	

Notes:

1. Port 2 and Port 0 only
2. V_{SS} = 0V = GND
3. The device operates down to V_{LV} of the specified frequency for V_{LV}. The minimum operational V_{CC} is determined on the value of the voltage V_{LV} at the ambient temperature. The V_{LV} increases as the temperature decreases.
4. V_{CC} = 4.5V to 5.5V, typical values measured at V_{CC} = 5.0V
5. Standard Mode (not Low EMI Mode)
6. Z86E08 only
7. All outputs unloaded and all inputs are at V_{CC} or V_{SS} level.
8. If analog comparator is selected, then the comparator inputs must be at V_{CC} level.

AC ELECTRICAL CHARACTERISTICS

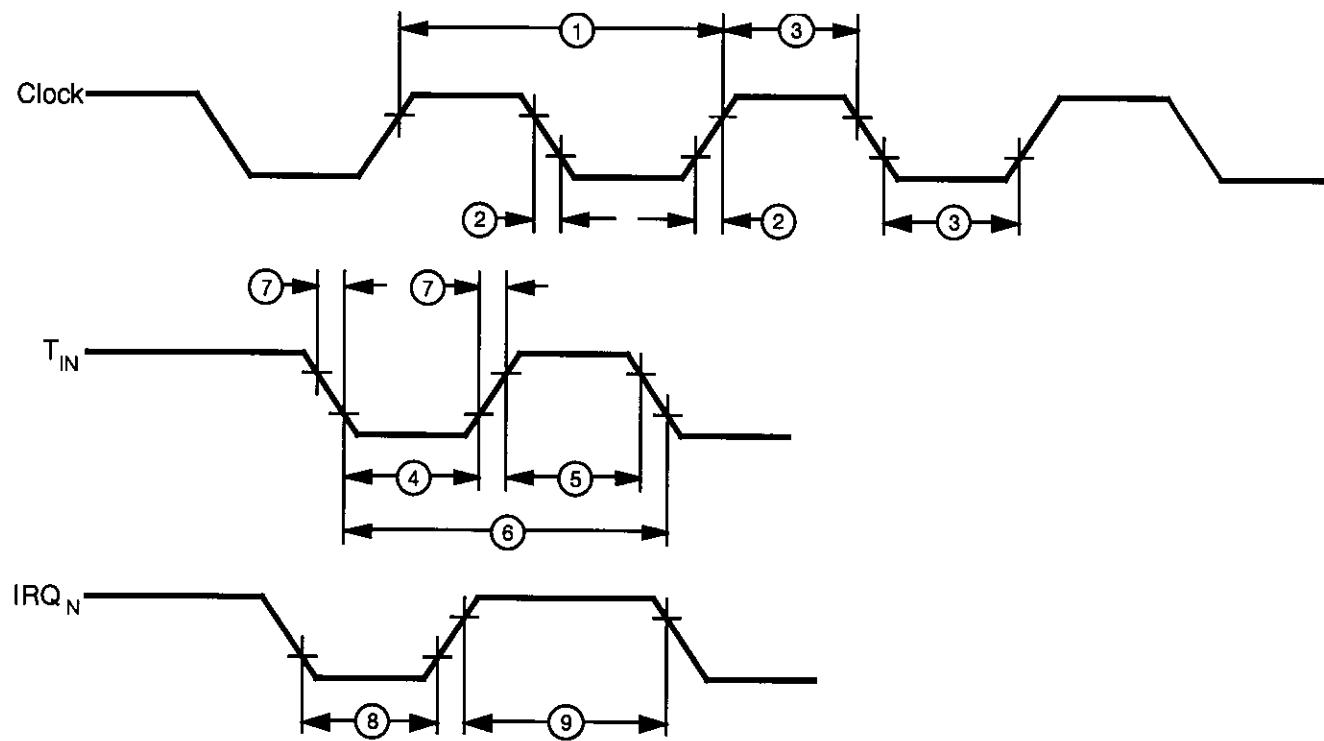


Figure 6. AC Electrical Timing Diagram

AC ELECTRICAL CHARACTERISTICS

Timing Table (Standard Mode for SCLK/TCLK = XTAL/2)
 Standard Temperature

15		$T_A = 0^\circ\text{C} \text{ to } +70^\circ\text{C}$							
No	Symbol	Parameter	V_{CC}	8 MHz		12 MHz		Units	Notes
				Min	Max	Min	Max		
1	TpC	Input Clock Period	4.5V	125	DC	83	DC	ns	1
			5.5V	125	DC	83	DC	ns	1
2	TrC,TfC	Clock Input Rise and Fall Times	4.5V		25		15	ns	1
			5.5V		25		15	ns	1
3	TwC	Input Clock Width	4.5V	62		41		ns	1
			5.5V	62		41		ns	1
4	TwTinL	Timer Input Low Width	4.5V	100		100		ns	1
			5.5V	70		70		ns	1
5	TwTinH	Timer Input High Width	4.5V	5TpC		5TpC			1
			5.5V	5TpC		5TpC			1
6	TpTin	Timer Input Period	4.5V		8TpC	8TpC			1
			5.5V		8TpC	8TpC			1
7	TrTin, TtTin	Timer Input Rise and Fall Time	4.5V	100		100	ns	1	
			5.5V	100		100	ns	1	
8	TwIL	Int. Request Input Low Time	4.5V	70		70		ns	1,2
			5.5V	70		70		ns	1,2
9	TwIH	Int. Request Input High Time	4.5V		5TpC	5TpC			1,2
			5.5V		5TpC	5TpC			1,2
10	Twdt	Watch-Dog Timer Delay Time for Timeout	4.5V	12		12		ms	1
			5.5V	12		12		ms	1
11	Tpqr	Power-On Reset Time	4.5V	20	80	20	80	ms	1
			5.5V	20	80	20	80	ms	1

Notes:

1. Timing Reference uses 0.7 V_{CC} for a logic 1 and 0.2 V_{CC} for a logic 0.
2. Interrupt request through Port 3 (P33-P31).

AC ELECTRICAL CHARACTERISTICS

Timing Table (Standard Mode for SCLK/TCLK = XTAL/2)

Extended Temperature

No	Symbol	Parameter	V _{CC}	T _A = -40 °C to +105 °C		12 MHz		Units	Notes
				8 MHz	12 MHz	Min	Max		
1	TpC	Input Clock Period	4.5V	125	DC	83	DC	ns	1
			5.5V	125	DC	83	DC	ns	1
2	TrC,TfC	Clock Input Rise and Fall Times	4.5V		25		15	ns	1
			5.5V		25		15	ns	1
3	TwC	Input Clock Width	4.5V		62		41	ns	1
			5.5V		62		41	ns	1
4	TwTinL	Timer Input Low Width	4.5V	70		70		ns	1
			5.5V	70		70		ns	1
5	TwTinH	Timer Input High Width	4.5V	5TpC		5TpC			1
			5.5V	5TpC		5TpC			1
6	TpTin	Timer Input Period	4.5V	8TpC		8TpC			1
			5.5V	8TpC		8TpC			1
7	TrTin, TtTin	Timer Input Rise and Fall Time	4.5V		100		100	ns	1
			5.5V		100		100	ns	1
8	TwIL	Int. Request Input Low Time	4.5V	70		70		ns	1,2
			5.5V	70		70		ns	1,2
9	TwIH	Int. Request Input High Time	4.5V	5TpC		5TpC			1,2
			5.5V	5TpC		5TpC			1,2
10	Twdt	Watch-Dog Timer Delay Time for Timeout	4.5V	10		10		ms	1
			5.5V	10		10		ms	1
11	Tp0R	Power-On Reset Time	4.5V	12	100	12	100	ms	1
			5.5V	12	100	12	100	ms	1

Notes:

1. Timing Reference uses 0.7 V_{CC} for a logic 1 and 0.2 V_{CC} for a logic 0.
2. Interrupt request made through Port 3 (P33-P31).

AC ELECTRICAL CHARACTERISTICS

Low Noise Mode, Standard Temperature

No	Symbol	Parameter	V_{CC}	$T_A = 0^\circ C \text{ to } +70^\circ C$				Units	Notes
				1 MHz	4 MHz	Min	Max		
1	TPC	Input Clock Period	4.5V	1000	DC	250	DC	ns	1
			5.5V	1000	DC	250	DC	ns	1
2	TrC TfC	Clock Input Rise and Fall Times	4.5V		25		25	ns	1
			5.5V		25		25	ns	1
3	TwC	Input Clock Width	4.5V	500		125		ns	1
			5.5V	500		125		ns	1
4.	TwTinL	Timer Input Low Width	4.5V	70		70		ns	1
			5.5V	70		70		ns	1
5	TwTinH	Timer Input High Width	4.5V	2.5TpC		2.5TpC			1
			5.5V	2.5TpC		2.5TpC			1
6	TpTin	Timer Input Period	4.5V	4TpC		4TpC			1
			5.5V	4TpC		4TpC			1
7	TrTin, TtTin	Timer Input Rise and Fall Time	4.5V		100		100	ns	1
			5.5V		100		100	ns	1
8	TwIL Low Time	Int. Request Input	4.5V	70		70		ns	1,2
			5.5V	70		70		ns	1,2
9	TwIH High Time	Int. Request Input	4.5V	2.5TpC		2.5TpC			1,2
			5.5V	2.5TpC		2.5TpC			1,2
10	Twdt	Watch-Dog Timer Delay Time for Timeout	4.5V	12		12		ms	1
			5.5V	12		12		ms	1

Notes:

1. Timing Reference uses 0.7 V_{CC} for a logic 1 and 0.2 V_{CC} for a logic 0.
2. Interrupt request through Port 3 (P33-P31).

AC ELECTRICAL CHARACTERISTICS (Continued)

Low Noise Mode, Extended Temperature

No	Symbol	Parameter	V_{CC}	$T_A = -40^{\circ}C \text{ to } +105^{\circ}C$				Units	Notes
				1 MHz	4 MHz	Min	Max		
1	TPC	Input Clock Period	4.5V	1000	DC	250	DC	ns	1
			5.5V	1000	DC	250	DC	ns	1
2	TrC TfC	Clock Input Rise and Fall Times	4.5V	25		25	ns	1	
			5.5V	25		25	ns	1	
3	TwC	Input Clock Width	4.5V	500		125	ns	1	
			5.5V	500		125	ns	1	
4.	TwTinL	Timer Input Low Width	4.5V	70		70	ns	1	
			5.5V	70		70	ns	1	
5	TwTinH	Timer Input High Width	4.5V	2.5TpC		2.5TpC		1	
			5.5V	2.5TpC		2.5TpC		1	
6	TpTin	Timer Input Period	4.5V		4TpC	4TpC		1	
			5.5V		4TpC	4TpC		1	
7	TrTin, TtTin	Timer Input Rise and Fall Time	4.5V	100		100	ns	1	
			5.5V	100		100	ns	1	
8	TwIL	Int. Request Input Low Time	4.5V	70		70	ns	1,2	
			5.5V	70		70	ns	1,2	
9	TwIH	Int. Request Input High Time	4.5V	2.5TpC		2.5TpC		1,2	
			5.5V	2.5TpC		2.5TpC		1,2	
10	Twdt	Watch-Dog Timer Delay Time for Timeout	4.5V	10		10	ms	1	
			5.5V	10		10	ms	1	

Notes:

1. Timing Reference uses 0.7 V_{CC} for a logic 1 and 0.2 V_{CC} for a logic 0.
2. Interrupt request through Port 3 (P33-P31).

LOW NOISE VERSION

Low EMI Emission

The Z86E04/E08 can be programmed to operate in a Low EMI Emission Mode by means of a mask ROM bit option. Use of this feature results in:

- All pre-driver slew rates reduced to 10 ns typical.
- Internal SCLK/TCLK operation limited to a maximum of 4 MHz–250 ns cycle time.

- Output drivers have resistances of 500 Ohms (typical).
- Oscillator divide-by-two circuitry eliminated.

The Low EMI Mode is mask-programmable to be selected by the customer at the time the ROM code is submitted.

PIN FUNCTIONS

OTP Programming Mode

D7–D0 Data Bus. Data can be read from, or written to, the EPROM through this data bus.

V_{CC} Power Supply. It is typically 5V during EPROM Read Mode and 6.4V during the other modes (Program, Program Verify, and so on).

CE Chip Enable (active Low). This pin is active during EPROM Read Mode, Program Mode, and Program Verify Mode.

OE Output Enable (active Low). This pin drives the Data Bus direction. When this pin is Low, the Data Bus is output. When High, the Data Bus is input.

EPM EPROM Program Mode. This pin controls the different EPROM Program Modes by applying different voltages.

V_{PP} Program Voltage. This pin supplies the program voltage.

Clear Clear (active High). This pin resets the internal address counter at the High Level.

Clock Address Clock. This pin is a clock input. The internal address counter increases by one with one clock cycle.

PGM Program Mode (active Low). A Low level at this pin programs the data to the EPROM through the Data Bus.

Application Precaution

The production test-mode environment may be enabled accidentally during normal operation if **excessive noise** surges above V_{CC} occur on the XTAL1 pin.

In addition, processor operation of Z8 OTP devices may be affected by **excessive noise** surges on the V_{PP}, CE, EPM, OE pins while the microcontroller is in Standard Mode.

Recommendations for dampening voltage surges in both test and OTP Mode include the following:

- Using a clamping diode to V_{CC}.
- Adding a capacitor to the affected pin.

Note: Programming the EPROM/Test Mode Disable option will prevent accidental entry into EPROM Mode or Test Mode.

PIN FUNCTIONS (Continued)

XTAL1, XTAL2 *Crystal In, Crystal Out* (time-based input and output, respectively). These pins connect a parallel-resonant crystal, LC, or an external single-phase clock (8 MHz or 12 MHz max) to the on-chip clock oscillator and buffer.

Port 0, P02–P00. Port 0 is a 3-bit bidirectional, Schmitt-triggered CMOS-compatible I/O port. These three I/O lines can be globally configured under software control to be inputs or outputs (Figure 7).

Auto Latch. The Auto Latch puts valid CMOS levels on all CMOS inputs (except P33, P32, P31) that are not externally driven. A valid CMOS level, rather than a floating node, reduces excessive supply current flow in the input buffer. On Power-up and Reset, the Auto Latch will set the ports to an undetermined state of 0 or 1. Default condition is Auto Latches enabled.

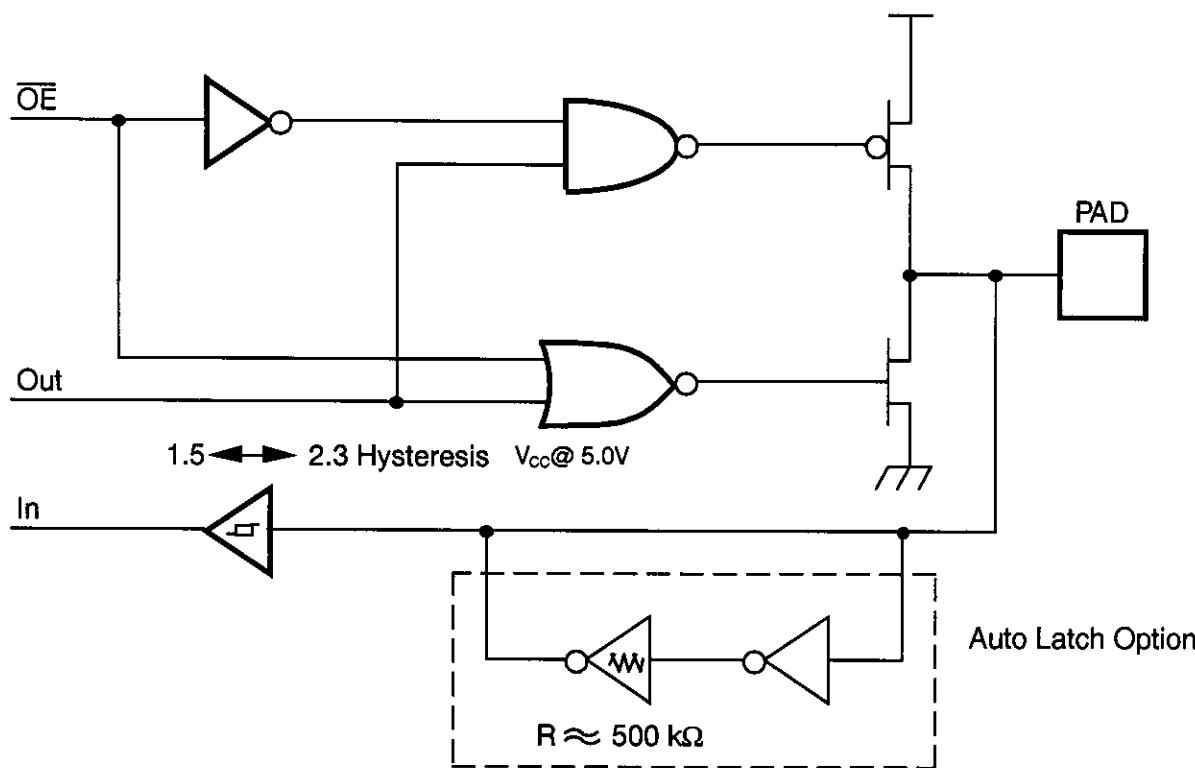
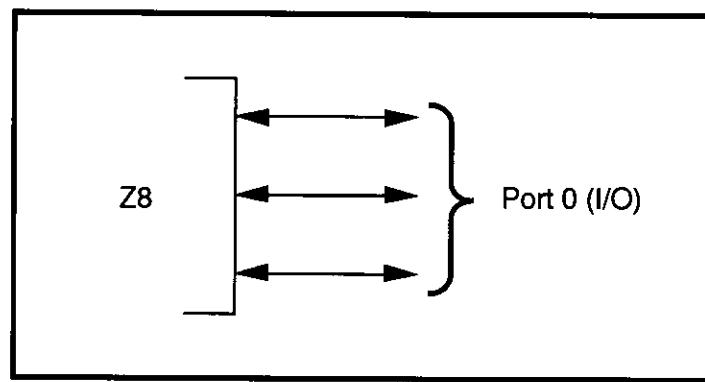


Figure 7. Port 0 Configuration

Port 2, P27–P20. Port 2 is an 8-bit, bit programmable, bi-directional, Schmitt-triggered CMOS-compatible I/O port. These eight I/O lines can be configured under software

control to be inputs or outputs, independently. Bits programmed as outputs can be globally programmed as either push-pull or open-drain (Figure 8).

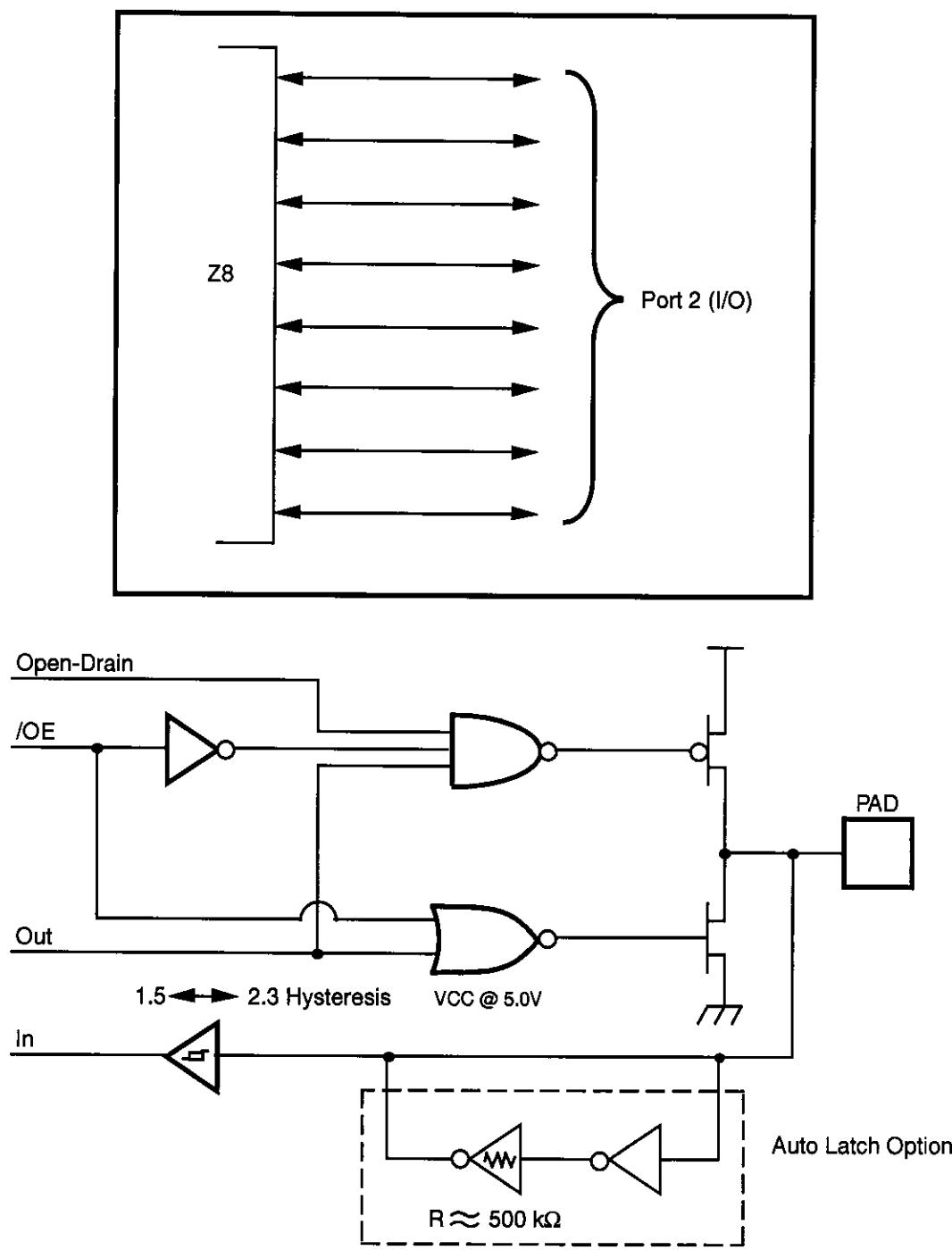
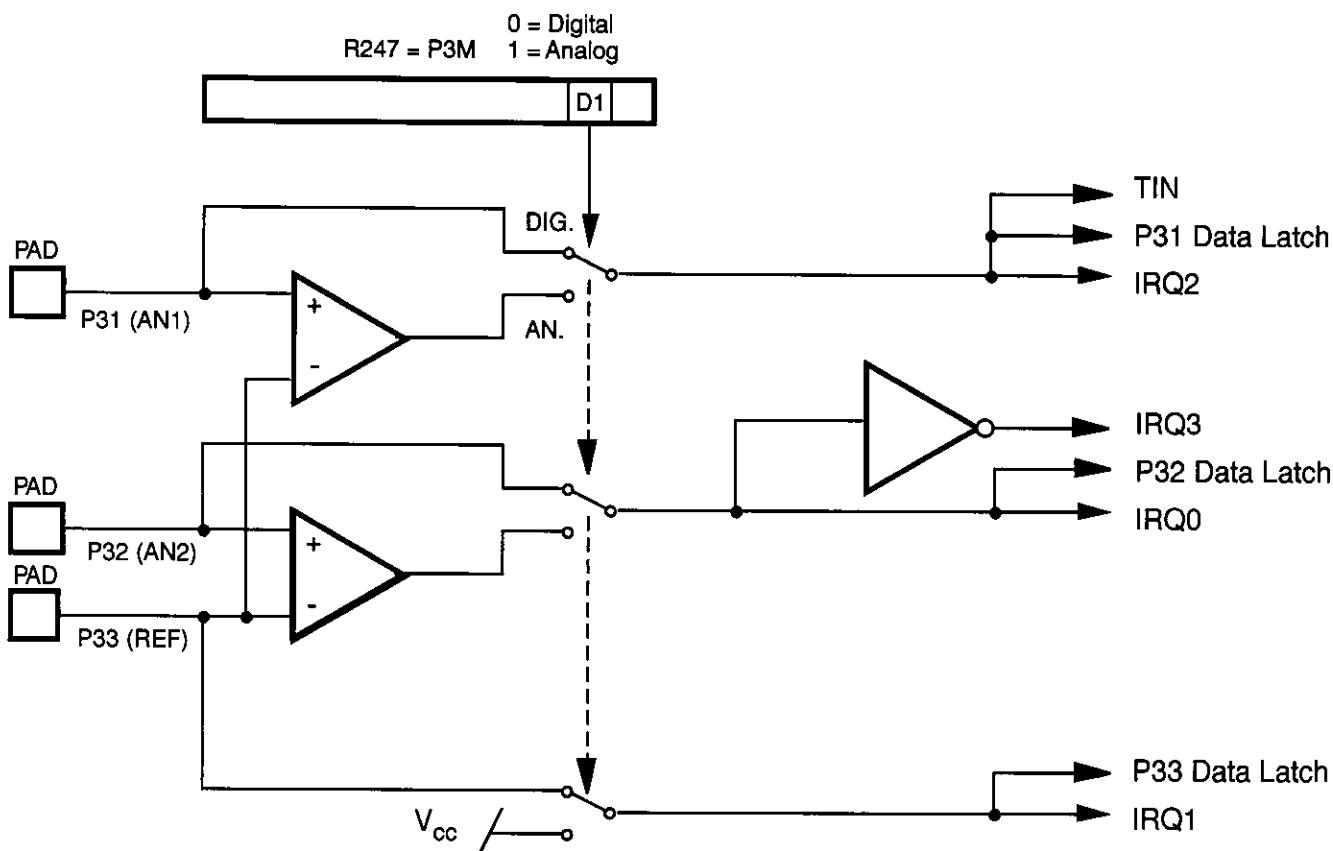
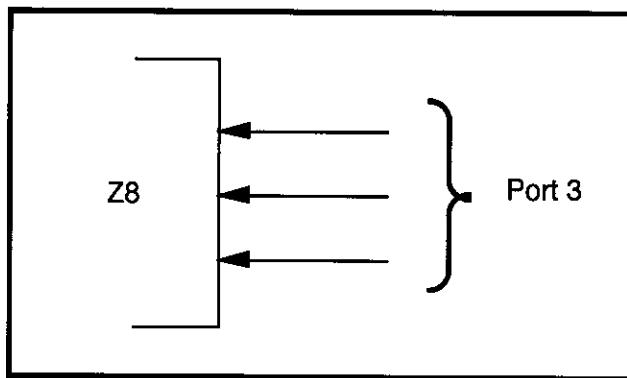


Figure 8. Port 2 Configuration

PIN FUNCTIONS (Continued)

Port 3, P33–P31. Port 3 is a 3-bit, CMOS-compatible port with three fixed input (P33–P31) lines. These three input lines can be configured under software control as digital Schmitt-trigger inputs or analog inputs.

These three input lines are also used as the interrupt sources IRQ0–IRQ3, and as the timer input signal T_{IN} (Figure 9).



IRQ 0,1,2 = Falling Edge Detection
IRQ3 = Rising Edge Detection

Figure 9. Port 3 Configuration

Comparator Inputs. Two analog comparators are added to input of Port 3, P31, and P32, for interface flexibility. The comparators reference voltage P33 (REF) is common to both comparators.

Typical applications for the on-board comparators; Zero crossing detection, A/D conversion, voltage scaling, and threshold detection. In Analog Mode, P33 input functions serve as a reference voltage to the comparators.

The dual comparator (common inverting terminal) features a single power supply which discontinues power in STOP

Mode. The common voltage range is 0–4 V when the V_{CC} is 5.0V; the power supply and common mode rejection ratios are 90 dB and 60 dB, respectively.

Interrupts are generated on either edge of Comparator 2's output, or on the falling edge of Comparator 1's output. The comparator output is used for interrupt generation, Port 3 data inputs, or T_{IN} through P31. Alternatively, the comparators can be disabled, freeing the reference input (P33) for use as IRQ1 and/or P33 input.

FUNCTIONAL DESCRIPTION

The following special functions have been incorporated into the Z8 devices to enhance the standard Z8 core architecture to provide the user with increased design flexibility.

RESET. This function is accomplished by means of a Power-On Reset or a Watch-Dog Timer Reset. Upon power-up, the Power-On Reset circuit waits for T_{POR} ms, plus 18 clock cycles, then starts program execution at address 000C (Hex) (Figure 10). The Z8 control registers' reset value is shown in Table 3.

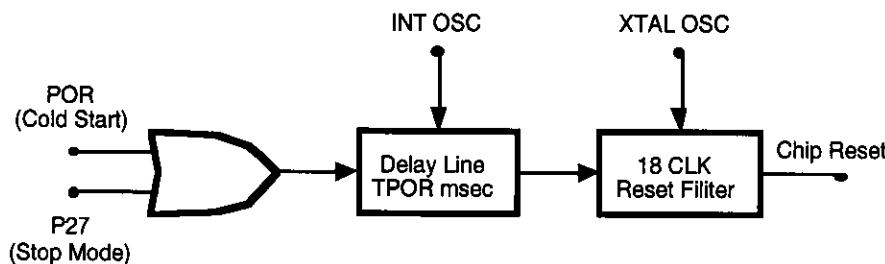


Figure 10. Internal Reset Configuration

Power-On Reset (POR). A timer circuit clocked by a dedicated on-board RC oscillator is used for a POR timer function. The POR time allows V_{CC} and the oscillator circuit to stabilize before instruction execution begins. The POR timer circuit is a one-shot timer triggered by one of the four following conditions:

- Power-bad to power-good status
- Stop-Mode Recovery
- WDT time-out
- WDH time-out

Watch-Dog Timer Reset. The WDT is a retriggerable one-shot timer that resets the Z8 if it reaches its terminal count. The WDT is initially enabled by executing the WDT instruction and is retriggered on subsequent execution of the WDT instruction. The timer circuit is driven by an on-board RC oscillator.

FUNCTIONAL DESCRIPTION (Continued)

Table 3. Control Registers

Addr.	Reg.	Reset Condition								Comments
		D7	D6	D5	D4	D3	D2	D1	D0	
FF	SPL	0	0	0	0	0	0	0	0	
FD	RP	0	0	0	0	0	0	0	0	
FC	FLAGS	U	U	U	U	U	U	U	U	
FB	IMR	0	U	U	U	U	U	U	U	
FA	IRQ	U	U	0	0	0	0	0	0	IRQ3 is used for positive edge detection
F9	IPR	U	U	U	U	U	U	U	U	
F8*	P01M	U	U	U	0	U	U	0	1	
F7*	P3M	U	U	U	U	U	U	0	0	
F6*	P2M	1	1	1	1	1	1	1	1	Inputs after reset
F5	PRE0	U	U	U	U	U	U	U	0	
F4	T0	U	U	U	U	U	U	U	U	
F3	PRE1	U	U	U	U	U	U	0	0	
F2	T1	U	U	U	U	U	U	U	U	
F1	TMR	0	0	0	0	0	0	0	0	

Note: *Registers are not reset after a STOP-Mode Recovery using P27 pin. A subsequent reset will cause these control registers to be reconfigured as shown in Table 4 and the user must avoid bus contention on the port pins or it may affect device reliability.

Program Memory. The Z86E04/E08 addresses up to 1K/2KB of Internal Program Memory (Figure 11). The first 12 bytes of program memory are reserved for the interrupt vectors. These locations contain six 16-bit vectors that correspond to the six available interrupts. Bytes 0–1024/2048 are on-chip one-time programmable ROM.

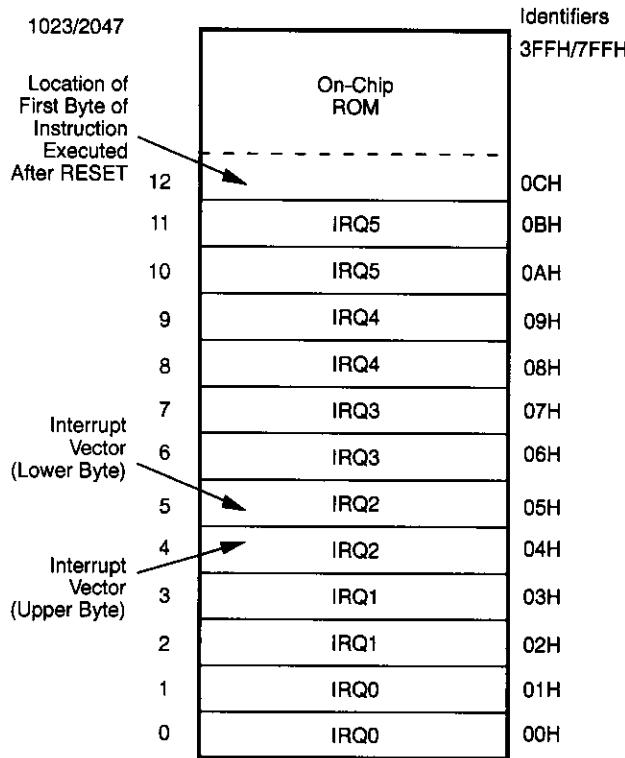


Figure 11. Program Memory Map

Register File. The Register File consists of three I/O port registers, 124 general-purpose registers, and 14 control and status registers R0–R3, R4–R127 and R241–R255, respectively (Figure 12). General-purpose registers occupy the 04H to 7FH address space. I/O ports are mapped as per the existing CMOS Z8.

Location	Identifiers
255 (FFH)	Stack Pointer (Bits 7-0)
254 (FE)	GPR
253 (FD)	RP
252 (FC)	FLAGS
251 (FB)	IMR
250 (FA)	IRQ
249 (F9)	IPR
248 (F8)	P01M
247 (F7)	P3M
246 (F6)	P2M
245 (F5)	PRE0
244 (F4)	T0
243 (F3)	PRE1
242 (F2)	T1
241 (F1H)	TMR
128	Not Implemented
127 (7FH)	General-Purpose Registers
4	
3	P3
2	P2
1	P1
0 (00H)	P0

Figure 12. Register File